

**IN74LV164**

**8-BIT SERIAL-IN/PARALLEL-OUT SHIFT REGISTER**

The IN74LV164 is a low-voltage Si-gate CMOS device and is pin and function compatible with the IN74HC/HCT164.

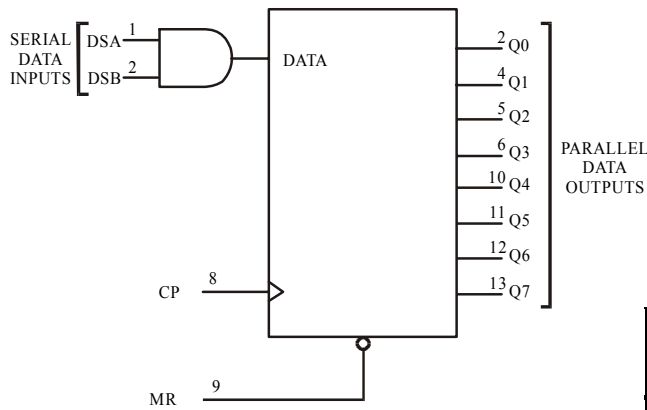
The IN74LV164 is an 8-bit edge-triggered shift register with serial data entry and an output from each of the eight stages. Data is entered serially through one of two inputs (DSA or DSB); either input can be used as an active HIGH enable for data entry through the other input. Both inputs must be connected together or an unused input must be tied HIGH.

Data shifts one place to the right on each LOW-to-HIGH transition of the clock (CP) input and enters into Q<sub>0</sub>, which is the logical AND of the two data inputs (DSA, DSB) that existed one set-up time prior to the rising clock edge.

A LOW on the master reset ( $\overline{\text{MR}}$ ) input overrides all other inputs and clears the register asynchronously, forcing all outputs LOW.

- Outputs Directly Interface to CMOS, NMOS, and TTL
- Operating Voltage Range: 1.2 to 5.5 V
- Low Input Current: 1.0  $\mu\text{A}$ , 0.1  $\mu\text{A}$  at T = 25 °C
- Output Current: 6 mA at V<sub>CC</sub> = 3.0 V; 12 mA at V<sub>CC</sub> = 4.5 V
- High Noise Immunity Characteristic of CMOS Devices

**LOGIC DIAGRAM**



PIN 14=V<sub>CC</sub>  
PIN 7 = GND

N SUFFIX  
PLASTIC DIP

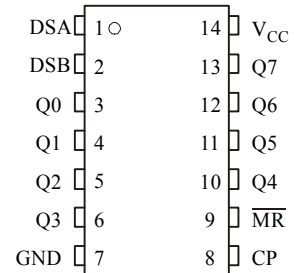
D SUFFIX  
SO

**ORDERING INFORMATION**

<b>IN74LV164N</b>	Plastic DIP
<b>IN74LV164D</b>	SOIC
<b>IZ74LV164</b>	chip

T<sub>A</sub> = -40° to 125° C for all packages

**PIN ASSIGNMENT**



**FUNCTION TABLE**

Inputs				Outputs		
$\overline{\text{MR}}$	CP	DSA	DSB	Q0	Q1 ... Q7	
L	X	X	X	L	L ... L	
H		L	L	L	Q0 ... Q6	
H		L	H	L	Q0 ... Q6	
H		H	L	L	Q0 ... Q6	
H		H	H	H	Q0 ... Q6	

H = high voltage level  
L = low voltage level  
X = don't care

**MAXIMUM RATINGS\***

Symbol	Parameter	Value	Unit
V <sub>CC</sub>	DC supply voltage	-0.5 to + 7.0	V
I <sub>IK</sub> * <sup>1</sup>	DC Input diode current	±20	mA
I <sub>OK</sub> * <sup>2</sup>	DC Output diode current	±50	mA
I <sub>O</sub> * <sup>3</sup>	DC Output source or sink current	±25	mA
I <sub>CC</sub>	V <sub>CC</sub> current	±50	mA
I <sub>GND</sub>	GND current	±50	mA
P <sub>D</sub>	Power dissipation per package: * <sup>4</sup> Plastic DIP SO	750 500	mW
T <sub>stg</sub>	Storage Temperature	-65 to +150	°C
T <sub>L</sub>	Lead Temperature, 1.5 mm (Plastic DIP Package), 0.3 mm (SO Package) from Case for 4 Seconds	260	°C

\*Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the Recommended Operating Conditions.

\*<sup>1</sup> V<sub>I</sub> < -0.5 V or V<sub>I</sub> > V<sub>CC</sub> + 0.5 V.

\*<sup>2</sup> V<sub>O</sub> < -0.5 V or V<sub>O</sub> > V<sub>CC</sub> + 0.5 V.

\*<sup>3</sup> -0.5 V < V<sub>O</sub> < V<sub>CC</sub> + 0.5 V.

\*<sup>4</sup> Derating - Plastic DIP: - 12 mW/°C from 70° to 125°C  
SO Package: : - 8 mW/°C from 70° to 125°C

**RECOMMENDED OPERATING CONDITIONS**

Symbol	Parameter	Min	Max	Unit
V <sub>CC</sub>	DC Supply Voltage	1.2	5.5	V
V <sub>I</sub>	Input Voltage	0	V <sub>CC</sub>	V
V <sub>O</sub>	Output Voltage	0	V <sub>CC</sub>	V
T <sub>A</sub>	Operating Temperature, All Package Types	-40	+125	°C
t <sub>r</sub> , t <sub>f</sub>	Input Rise and Fall Time (Figure 1)			ns
	1.0 V ≤ V <sub>CC</sub> < 2.0 V	0	500	
	2.0 V ≤ V <sub>CC</sub> < 2.7 V	0	200	
	2.7 V ≤ V <sub>CC</sub> < 3.6 V	0	100	
	3.6 V ≤ V <sub>CC</sub> ≤ 5.5 V	0	50	

This device contains protection circuitry to guard against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to this high-impedance circuit. For proper operation, V<sub>IN</sub> and V<sub>OUT</sub> should be constrained to the range GND ≤ (V<sub>IN</sub> or V<sub>OUT</sub>) ≤ V<sub>CC</sub>.

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either GND or V<sub>CC</sub>). Unused outputs must be left open.

## DC ELECTRICAL CHARACTERISTICS (Voltages Referenced to GND)

Symbol	Parameter	Test conditions	V <sub>CC</sub> V	Guaranteed Limit						Unit	
				25°C to -40°C		85°C		125°C			
				min	max	min	max	min	max		
V <sub>IH</sub>	HIGH level input voltage		1.2	0.9	-	0.9	-	0.9	-	V	
			2.0	1.4	-	1.4	-	1.4	-		
			2.7	2.0	-	2.0	-	2.0	-		
			3.0	2.0	-	2.0	-	2.0	-		
			3.6	2.0	-	2.0	-	2.0	-		
			4.5	3.15	-	3.15	-	3.15	-		
			5.5	3.85	-	3.85	-	3.85	-		
V <sub>IL</sub>	LOW level input voltage		1.2	-	0.3	-	0.3	-	0.3	V	
			2.0	-	0.6	-	0.6	-	0.6		
			2.7	-	0.8	-	0.8	-	0.8		
			3.0	-	0.8	-	0.8	-	0.8		
			3.6	-	0.8	-	0.8	-	0.8		
			4.5	-	1.35	-	1.35	-	1.35		
			5.5	-	1.65	-	1.65	-	1.65		
V <sub>OH</sub>	HIGH level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>O</sub> = -100 μA	1.2	1.05	-	1.0	-	1.0	-	V	
			2.0	1.85	-	1.8	-	1.8	-		
			2.7	2.55	-	2.5	-	2.5	-		
			3.0	2.85	-	2.8	-	2.8	-		
			3.6	3.45	-	3.4	-	3.4	-		
			4.5	4.35	-	4.3	-	4.3	-		
			5.5	5.35	-	5.3	-	5.3	-		
			V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>O</sub> = -6.0 mA	3.0	2.48	-	2.40	-	2.20	-	V
			V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>O</sub> = -12.0 mA	4.5	3.70	-	3.60	-	3.50	-	V
V <sub>OL</sub>	LOW level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>O</sub> = 100 μA	1.2	-	0.15	-	0.2	-	0.2	V	
			2.0	-	0.15	-	0.2	-	0.2		
			2.7	-	0.15	-	0.2	-	0.2		
			3.0	-	0.15	-	0.2	-	0.2		
			3.6	-	0.15	-	0.2	-	0.2		
			4.5	-	0.15	-	0.2	-	0.2		
			5.5	-	0.15	-	0.2	-	0.2		
			V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>O</sub> = 6.0 mA	3.0	-	0.33	-	0.4	-	0.5	V
			V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> I <sub>O</sub> = 12.0 mA	4.5	-	0.40	-	0.55	-	0.65	V
I <sub>I</sub>	Input current	V <sub>I</sub> = V <sub>CC</sub> or 0 V	5.5	-	±0.1	-	±1.0	-	±1.0	μA	
I <sub>CC</sub>	Supply current	V <sub>I</sub> = V <sub>CC</sub> or 0 V I <sub>O</sub> = 0 μA	5.5	-	8.0	-	80	-	160	μA	
I <sub>CC1</sub>	Supply current	V <sub>I</sub> = V <sub>CC</sub> - 0.6 V	2.7 3.6	-	0.2	-	0.5	-	0.85	mA	

AC ELECTRICAL CHARACTERISTICS ( $C_L=50$  pF,  $t_r=t_f=2.5$  ns,  $R_L=1$  k $\Omega$ )

Symbol	Parameter	Test conditions	V <sub>CC</sub> V	Guaranteed Limit						Unit
				25°C to -40°C		85°C		125°C		
				min	max	min	max	min	max	
t <sub>PHL</sub> , t <sub>PLH</sub>	Propagation delay, CP to Qn	V <sub>I</sub> = 0 V or V <sub>I</sub> Figure 1 and 4	1.2	-	150	-	180	-	210	ns
			2.0	-	30	-	39	-	49	
			2.7	-	23	-	29	-	36	
			3.0	-	18	-	23	-	29	
			4.5	-	15	-	19	-	24	
t <sub>PHL</sub>	Propagation delay, $\overline{\text{MR}}$ to Qn	V <sub>I</sub> = 0 V or V <sub>I</sub> Figure 1 and 4	1.2	-	150	-	180	-	210	ns
			2.0	-	30	-	39	-	49	
			2.7	-	23	-	29	-	36	
			3.0	-	18	-	23	-	29	
			4.5	-	15	-	19	-	24	
t <sub>w</sub>	Pulse Width, CP or MR	V <sub>I</sub> = 0 V or V <sub>I</sub> Figure 1	1.2	100	-	130	-	160	-	ns
			2.0	28	-	34	-	41	-	
			2.7	21	-	25	-	30	-	
			3.0	17	-	20	-	24	-	
			4.5	14	-	17	-	20	-	
t <sub>su</sub>	Setup Time, DSA or DSB to CP	V <sub>I</sub> = 0 V or V <sub>I</sub> Figure 3	1.2	60	-	80	-	100	-	ns
			2.0	19	-	22	-	26	-	
			2.7	13	-	16	-	19	-	
			3.0	11	-	13	-	15	-	
			4.5	9	-	11	-	13	-	
t <sub>h</sub>	Hold Time, DSA or DSB to CP	V <sub>I</sub> = 0 V or V <sub>I</sub> Figure 3	1.2	50	-	50	-	50	-	ns
			2.0	5	-	5	-	5	-	
			2.7	5	-	5	-	5	-	
			3.0	5	-	5	-	5	-	
			4.5	5	-	5	-	5	-	
t <sub>rec</sub>	Recovery Time, $\overline{\text{MR}}$ to CP	V <sub>I</sub> = 0 V or V <sub>I</sub> Figure 2	1.2	70	-	100	-	130	-	ns
			2.0	15	-	19	-	24	-	
			2.7	11	-	14	-	18	-	
			3.0	9	-	11	-	14	-	
			4.5	8	-	10	-	12	-	
f <sub>max</sub>	Clock Frequency	V <sub>I</sub> = 0 V or V <sub>I</sub> Figure 1 and 4	1.2	-	2	-	1	-	1	MHz
			2.0	-	16	-	14	-	12	
			2.7	-	22	-	19	-	16	
			3.0	-	27	-	24	-	20	
			4.5	-	32	-	27	-	24	
C <sub>I</sub>	Input capacitance		5.0	-	7.0	-	-	-	pF	
C <sub>PD</sub>	Power dissipation capacitance	V <sub>I</sub> = 0 V or V <sub>CC</sub>	5.5	-	80	-	-	-	pF	

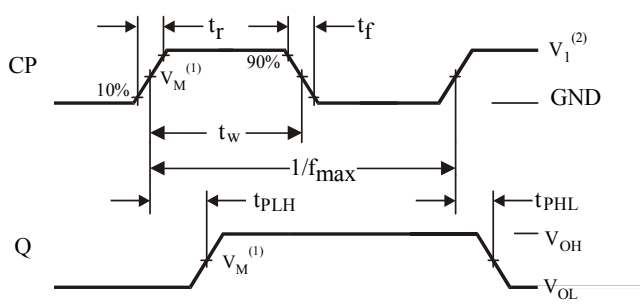


Figure 1. Switching Waveforms

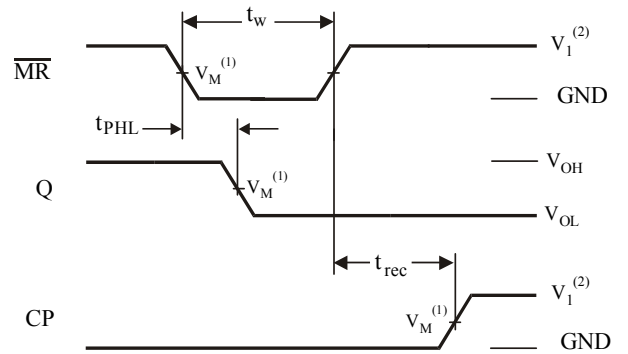


Figure 2. Switching Waveforms

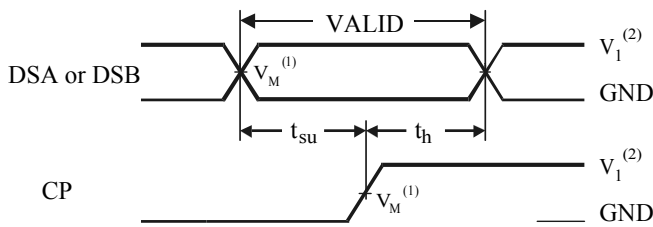
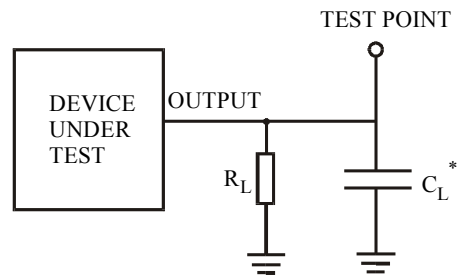


Figure 3. Switching Waveforms



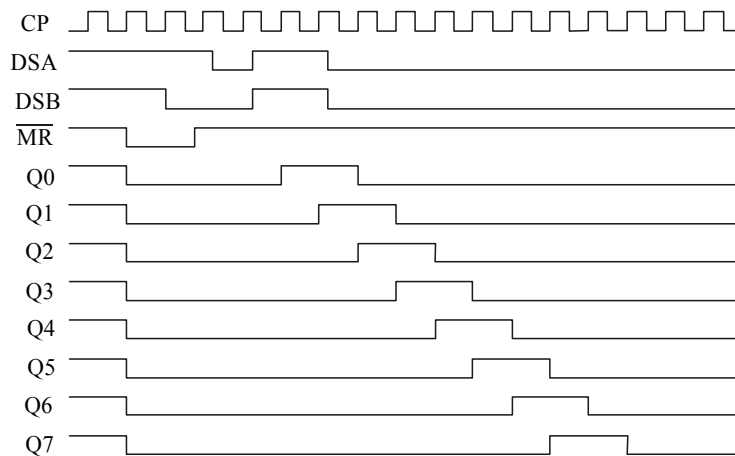
\* Includes all probe and jig capacitance

Figure 4. Test Circuit

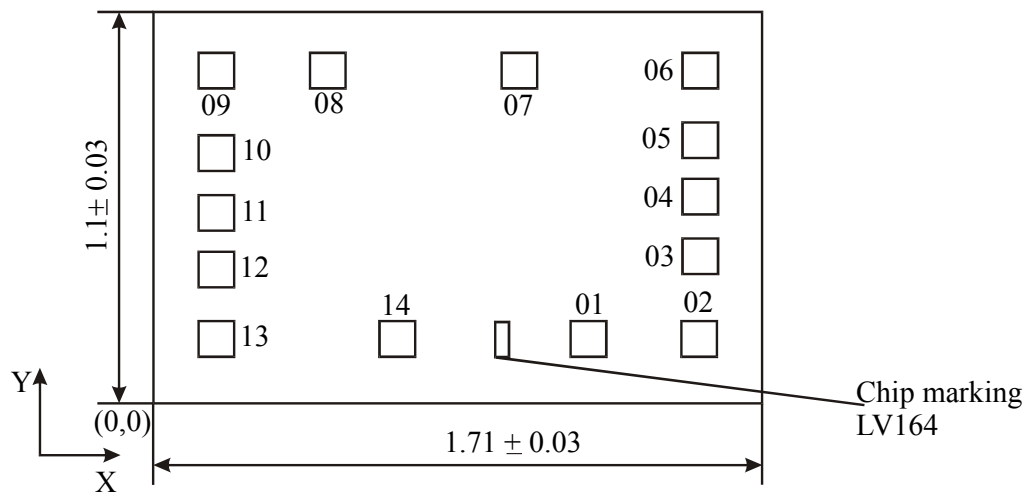
Note:

- (1)  $V_M = 1.5 \text{ V}$  at  $V_{CC} = 2.7 \text{ V}$   
 $V_M = 0.5 \cdot V_{CC}$  at  $V_{CC} = 1.2 \text{ V}, 2.0 \text{ V}, 3.0 \text{ V}, 4.5 \text{ V}$
- (2)  $V_1 = V_{CC}$  at  $V_{CC} = 1.2 \text{ V}, 2.0 \text{ V}, 2.7 \text{ V}, 4.5 \text{ V}$   
 $V_1 = 2.7 \text{ V}$  at  $V_{CC} = 3.0 \text{ V}$

TIMING DIAGRAM



## CHIP PAD DIAGRAM



**Location of marking (mm):** left lower corner  $x=0.960$ ,  $y=0.130$ .

**Chip thickness:**  $0.46 \pm 0.02$  ( $0.35 \pm 0.02$ ) mm.

## PAD LOCATION

Pad No	Symbol	Location (left lower corner), mm		Pad size, mm
		X	Y	
01	DSA	1.172	0.131	0.100 x 0.100
02	DSB	1.486	0.131	0.100 x 0.100
03	Q0	1.486	0.363	0.100 x 0.100
04	Q1	1.486	0.531	0.100 x 0.100
05	Q2	1.486	0.689	0.100 x 0.100
06	Q3	1.486	0.885	0.100 x 0.100
07	GND	0.978	0.885	0.100 x 0.100
08	CP	0.440	0.885	0.100 x 0.100
09	MR	0.127	0.885	0.100 x 0.100
10	Q4	0.127	0.653	0.100 x 0.100
11	Q5	0.127	0.485	0.100 x 0.100
12	Q6	0.127	0.326	0.100 x 0.100
13	Q7	0.127	0.131	0.100 x 0.100
14	V <sub>CC</sub>	0.635	0.131	0.100 x 0.100

Note: Pad location is given as per passivation layer